

## *Virtual Training Course Outline*

# **Microwave Packaging Technology**

(3 Sessions, 2 hrs each)

**Instructor: Thomas J. Green, [TJ Green Associates, LLC](http://www.tjgreenllc.com)**

Microwave Hybrids, MICs, RF MMIC modules all require a unique set of materials and processes necessary to achieve reliable operations in extreme military and commercial environments, such as next generation 5G modules. This three-day course examines all aspects of microwave packaging from a practical perspective. The instructor shares valuable lessons learned from years of experience.

Design issues, material tradeoffs, process selection are all covered in detail with the goal of imparting useful information to the students so they can return to the workplace better equipped to assemble and manufacture reliable microwave hybrids for military, space and other hi reliability commercial and medical device applications.

This course is intended as an introductory to intermediate level course for process engineers, designers, quality engineers, and managers responsible for design and manufacture of microwave hybrids.



## **Course Outline**

### **Session 1**

- **Introduction to Microwave Technology**
  - Terminology and product definitions
  - Microwave hybrids, RF/MMIC modules
  - Military, space, commercial and medical products
- **Military Requirements Flow Down and Design Guidelines**
  - MIL-PRF-38534 Hybrid Performance Specification
  - MIL-STD-883 Test Methods
- **Manufacturing Assembly Process Overview**
  - Basic hybrid microwave manufacturing process flows
  - Clean room requirements and industry protocols

- **Wafer Fabrication Processes**
  - GaAs Gallium Arsenide wafer fabrication
  - GaN Gallium Nitride on SiC
  - MMIC device features identification
  - Review of wafer fabrication defects at incoming inspection (e.g., airbridge and channel damage, excessive probe marks)
- **Substrate Technology**
  - Teflon PTFE (duroid) and other soft board material sets
  - Alumina ceramic substrate fabrication
- **Thin Film Processes on Ceramic**
  - Sputtering vs. vapor deposition
  - Photolithography, coat and etch
  - Plating processes and specifications Laser Trimming of Precision Thin Film Resistors
- **Material and Process Fundamentals for Component Attach**
  - Silver epoxy attach of substrate and MMIC die
  - Solder and epoxy attach of discrete passive components
- **Eutectic Soldering Processes**
  - AuSn solder attach of GaAs chips
  - Issues with die voiding and how to detect

## **Session 2**

- **Die, substrate and package compatibility**
  - Coefficient of Thermal Expansion (CTE)
  - Material selection and design trade offs
- **Thermal Impedance and Importance of Minimizing Junction Temperature**
  - Simple excel spreadsheet demonstrates importance of proper material selection for typical microwave hybrid material sets
- **Packaging Design Considerations**
  - Thermal analysis, simulated stack up and junction temp calculations
- **Review of Defects from the Component Attach Processes**
- **Overview of Common Cleaning Processes and Potential Problems**
  - Wet chemicals, oxygen/argon plasma, UV Ozone
- **Wirebonding and Interconnect Process Overview**
  - Ultrasonic/thermosonic bonding
  - Thermocompression bonding
  - Ribbon bonding
  - Deep access bonding
  - Fine wire (.7 mil) bonding gate pads on FETs
- **Gap Welding**
- **Factors that affect yield and reliability**

- Lessons learned
- Review of defects from the wirebond process

### **Session 3**

- **Hermetic Packaging Process Overview**
  - Seam sealing, laser welding aluminum alloys, solder sealing
- **Hermeticity Testing**
  - Traditional gross and fine helium leak testing per MIL-STD-883 TM 1014
- **Near Hermetic Packaging Options**
  - LCP and other packaging approaches
- **Design for Manufacturability (DFM)**
  - Rationale and significance of DFM
  - Typical problems encountered during hybrid manufacturing and how they can be prevented!
- **Course Summary**
- **Student Feedback and Course Critique**

### **INSTRUCTOR BIO**



**Thomas J. Green** has more than 43 years combined experience in industry/academia and the DoD. He earned a B.S from Lehigh University in Materials Engineering and an MEA from Univ of Utah. He is a recognized expert in materials and processes used to assemble hybrids, RF microwave modules, Class III medical implants, optoelectronics, and other types of hermetic/non-hermetic packaged microcircuits and sensors. He has considerable expertise in hermetic testing methods per TM 1014 and moisture related failures in general. He is a consultant to companies developing next gen microelectronics for military and space. Serving as a Research Scientist at the U.S. Air Force Rome Air Development Center, Tom worked as a reliability engineer analyzing component failures and in industry, he was the process engineer at Lockheed Denver. He has invaluable experience in wirebond, die attach, hermetic sealing, FA and root cause identification and is an expert in the visual inspection criteria for hybrids and microcircuits Mil-Std-883 TM 2010 and TM 2017. For the last 20 years, Tom's expertise has helped position TJ Green Associates, LLC as a recognized industry leader in teaching and consulting services for high-reliability military, space, and medical device applications. Tom is a Fellow of IMAPS (International Microelectronics and Packaging Society) and retired LtCol USAFR with 28 years of service.